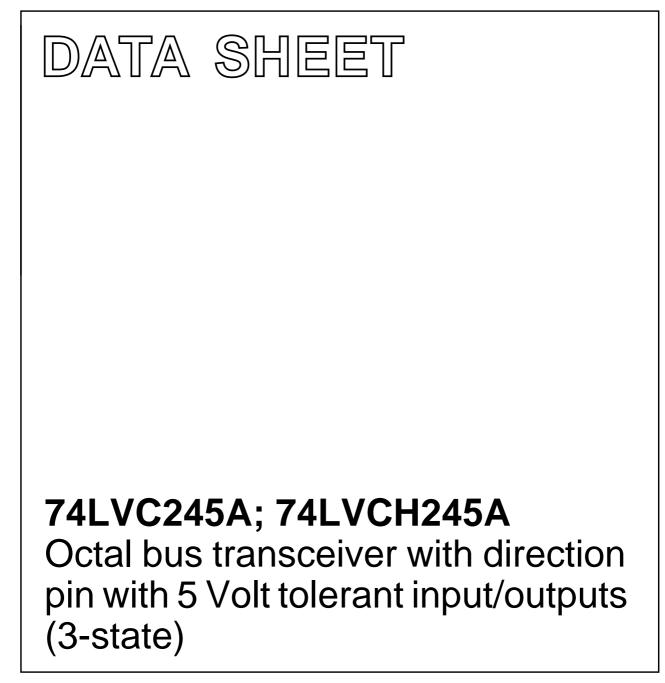
INTEGRATED CIRCUITS



Product specification Supersedes data of 1997 Dec 19 2002 Jun 20



74LVC245A;

74LVCH245A

## Octal bus transceiver with direction pin with 5 Volt tolerant input/outputs (3-state)

### FEATURES

- 5 V tolerant inputs/outputs for interfacing with 5 V logic
- Wide supply voltage range from 1.2 to 3.6 V
- CMOS low power consumption
- Direct interface with TTL levels
- Inputs accept voltages up to 5.5 V
- Complies with JEDEC standard no. 8-1A
- High-imp edance when  $V_{CC} = 0 V$
- Bushold on all data inputs (74LVCH245A only)
- Specified from -40 to +85 °C and -40 to +125 °C.

#### DESCRIPTION

The 74LVC245A/74LVCH245A is a high-performance, low-power, low-voltage, Si-gate CMOS device, superior to most advanced CMOS compatible TTL families.

Inputs can be driven from either 3.3 or 5 V devices. In 3-state operation outputs can handle 5 V. These features allow the use of these devices as translators in a mixed 3.3 and 5 V environment.

The 74LVC245A/74LVCH245A is an octal transceiver with non-inverting 3-state bus compatible outputs in both send and receive directions.

The 74LVC245A/74LVCH245A has an output enable ( $\overline{OE}$ ) input for easy cascading and a send/receive (DIR) input for direction control.  $\overline{OE}$  controls the outputs so that the buses are effectively isolated.

### QUICK REFERENCE DATA

GND = 0 V; T<sub>amb</sub> = 25 °C; t<sub>r</sub> = t<sub>f</sub>  $\leq$  2.5 ns.

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	propagation delay $A_n$ to $B_n$ , $B_n$ to $A_n$	$C_{L} = 50 \text{ pF}; V_{CC} = 3.3 \text{ V}$	2.9	ns
CI	input capacitance		4.0	pF
C <sub>I/O</sub>	input/output capacitance		10.0	pF
C <sub>PD</sub>	power dissipation capacitance per buffer	$V_{CC}$ = 3.3 V; notes 1 and 2	15	pF

### Notes

1.  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).

 $P_{D} = C_{PD} \times V_{CC}^{2} \times f_{i} + \Sigma (C_{L} \times V_{CC}^{2} \times f_{o}) \text{ where:}$ 

 $f_i$  = input frequency in MHz;

 $f_o = output frequency in MHz;$ 

 $C_L$  = output load capacitance in pF;

V<sub>CC</sub> = supply voltage in Volts;

 $\Sigma(C_L \times V_{CC}^2 \times f_o)$  = sum of the outputs.

2. The condition is  $V_I = GND$  to  $V_{CC}$ .

## 74LVC245A; 74LVCH245A

### **ORDERING INFORMATION**

TYPE NUMBER	TEMPERATURE RANGE	PACKAGE					
	I EMPERATURE RANGE	PINS	PACKAGE	MATERIAL	CODE		
74LVC245AD	-40 to +125 °C	20	SO	plastic	SOT163-1		
74LVC245ADB	-40 to +125 °C	20	SSOP	plastic	SOT339-1		
74LVC245APW	-40 to +125 °C	20	TSSOP	plastic	SOT360-1		
74LVCH245AD	–40 to +125 °C	20	SO	plastic	SOT163-1		
74LVCH245ADB	-40 to +125 °C	20	SSOP	plastic	SOT339-1		
74LVCH245APW	–40 to +125 °C	20	TSSOP	plastic	SOT360-1		

### FUNCTION TABLE

See note 1.

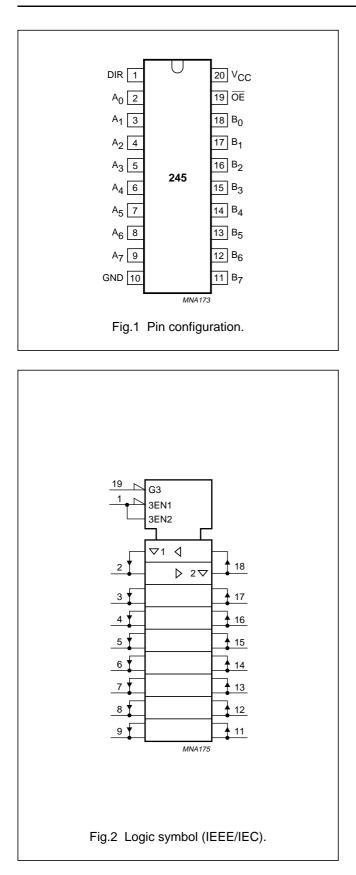
INF	TUT	INPUTS/OUTPUT		
ŌĒ	DIR	A <sub>n</sub>	B <sub>n</sub>	
L	L	A = B	input	
L	Н	input	B = A	
Н	Х	Z	Z	

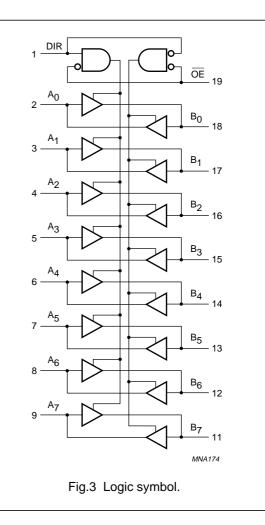
### Note

- 1. H = HIGH voltage level;
  - L = LOW voltage level;
  - X = don't care;
  - Z = high-impedance OFF-state.

## 

PIN	SYMBOL	DESCRIPTION
1	DIR	direction control
2	A <sub>0</sub>	data inputs/output
3	A <sub>1</sub>	data inputs/output
4	A <sub>2</sub>	data inputs/output
5	A <sub>3</sub>	data inputs/output
6	A <sub>4</sub>	data inputs/output
7	A <sub>5</sub>	data inputs/output
8	A <sub>6</sub>	data inputs/output
9	A <sub>7</sub>	data inputs/output
10	GND	ground (0 V)
11	B <sub>7</sub>	data inputs/output
12	B <sub>6</sub>	data inputs/output
13	B <sub>5</sub>	data inputs/output
14	B <sub>4</sub>	data inputs/output
15	B <sub>3</sub>	data inputs/output
16	B <sub>2</sub>	data inputs/output
17	B <sub>1</sub>	data inputs/output
18	B <sub>0</sub>	data inputs/output
19	ŌĒ	output enable input (active LOW)
20	V <sub>CC</sub>	supply voltage





## 74LVC245A; 74LVCH245A

### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CC</sub>	supply voltage	for maximum speed performance	2.7	3.6	V
		for low-voltage applications	1.2	3.6	V
VI	input voltage		0	5.5	V
Vo	output voltage	output HIGH or LOW state	0	V <sub>CC</sub>	V
		output 3-state	0	5.5	V
T <sub>amb</sub>	operating ambient temperature		-40	+125	°C
t <sub>r</sub> , t <sub>f</sub>	input rise and fall times	V <sub>CC</sub> = 1.2 to 2.7 V	0	20	ns/V
		V <sub>CC</sub> = 2.7 to 3.6 V	0	10	ns/V

#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134); voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CC</sub>	supply voltage		-0.5	+6.5	V
I <sub>IK</sub>	input diode current	V <sub>1</sub> < 0	_	-50	mA
VI	input voltage	note 1	-0.5	+6.5	V
I <sub>OK</sub>	output diode current	$V_{\rm O}$ > $V_{\rm CC}$ or $V_{\rm O}$ < 0	_	±50	mA
Vo	output voltage	output HIGH or LOW state; note 1	-0.5	V <sub>CC</sub> + 0.5	V
		output 3-state; note 1	-0.5	+6.5	V
lo	output source or sink current	$V_{O} = 0$ to $V_{CC}$	_	±50	mA
I <sub>CC</sub> , I <sub>GND</sub>	V <sub>CC</sub> or GND current		-	±100	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	power dissipation per package				
	SO	above 70 °C derate linearly with 8 mW/K	_	500	mW
	SSOP and TSSOP	above 60 °C derate linearly with 5.5 mW/K	_	500	mW

Note

1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

### 74LVC245A; 74LVCH245A

### DC CHARACTERISTICS

Over recommended operating conditions; voltages are referenced to GND (ground = 0 V).

		TEST CONDITIONS		T <sub>amb</sub> (°C)					
SYMBOL	PARAMETER	07UED		-40 to +85			-40 to +125		UNIT
		OTHER	V <sub>CC</sub> (V)	MIN.	<b>TYP.</b> <sup>(1)</sup>	MAX.	MIN.	MAX.	1
VIH	HIGH-level input		1.2	V <sub>CC</sub>	-	_	V <sub>CC</sub>	-	V
	voltage		2.7 to 3.6	2.0	_	-	2.0	-	V
V <sub>IL</sub>	LOW-level input		1.2	-	_	0	-	0	V
	voltage		2.7 to 3.6	-	_	0.8	-	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH} \text{ or } V_{IL};$ $I_O = -100 \ \mu\text{A}$	2.7 to 3.6	V <sub>CC</sub> - 0.2	V <sub>CC</sub>	-	V <sub>CC</sub> – 0.3	-	V
		$V_I = V_{IH} \text{ or } V_{IL};$ $I_O = -12 \text{ mA}$	2.7	$V_{CC} - 0.5$	-	-	V <sub>CC</sub> - 0.65	-	V
		$V_{I} = V_{IH} \text{ or } V_{IL};$ $I_{O} = -18 \text{ mA}$	3.0	V <sub>CC</sub> - 0.6	-	-	V <sub>CC</sub> – 0.75	-	V
		$V_{I} = V_{IH} \text{ or } V_{IL};$ $I_{O} = -24 \text{ mA}$	3.0	V <sub>CC</sub> - 0.8	-	-	V <sub>CC</sub> – 1	-	V
	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 100 μA	2.7 to 3.6	-	0	0.2	-	0.3	V
		$V_{I} = V_{IH} \text{ or } V_{IL};$ $I_{O} = 12 \text{ mA}$	2.7	-	-	0.4	-	0.6	V
		$V_{I} = V_{IH} \text{ or } V_{IL};$ $I_{O} = 24 \text{ mA}$	3.0	-	-	0.55	-	0.8	V
I <sub>LI</sub>	input leakage current	$V_1 = 5.5 V \text{ or GND};$ note 2	3.6	-	±0.1	±5	-	±20	μΑ
I <sub>OZ</sub>	3-state output OFF-state current	$V_I = V_{IH} \text{ or } V_{IL};$ notes 2 and 3; $V_O = 5.5 \text{ V or GND}$	3.6	-	±0.1	±5	-	±20	μA
l <sub>off</sub>	power off leakage supply	$V_{\rm I}$ or $V_{\rm O}$ = 5.5 V	0.0	-	±0.1	±10	-	±20	μA
I <sub>CC</sub>	quiescent supply current	$V_{I} = V_{CC} \text{ or GND};$ $I_{O} = 0$	3.6	-	0.1	10	-	40	μA
Δl <sub>CC</sub>	additional quiescent supply current per in. pin	$V_1 = V_{CC} - 0.6 V;$ $I_0 = 0$	2.7 to 3.6	-	5	500	-	5000	μA

## 74LVC245A; 74LVCH245A

		TEST CONDITIONS		T <sub>amb</sub> (°C)					
SYMBOL	PARAMETER		V 00	-40	0 to +85		-40 to +125		UNIT
		OTHER	V <sub>CC</sub> (V)	MIN.	<b>TYP.</b> <sup>(1)</sup>	MAX.	MIN.	MAX.	
I <sub>BHL</sub>	bushold LOW sustaining current	V <sub>I</sub> = 0.8 V; notes 4, 5 and 6	3.0	75	_	_	60	-	μA
I <sub>BHH</sub>	bushold HIGH sustaining current	V <sub>I</sub> = 2.0 V; notes 4, 5 and 6	3.0	-75	-	_	-60	-	μA
I <sub>BHLO</sub>	bushold LOW overdrive current	notes 4, 5 and 7	3.6	500	-	_	500	-	μA
I <sub>BHHO</sub>	bushold HIGH overdrive current	notes 4, 5 and 7	3.6	-500	_	_	-500	_	μA

### Notes

1. All typical values are measured at V<sub>CC</sub> = 3.3 V and T<sub>amb</sub> = 25 °C.

2. For bushold parts, the bushold circuit is switched off when  $V_I > V_{CC}$  allowing 5.5 V on the input terminal.

3. For I/O ports the parameter  $I_{OZ}$  includes the input leakage current.

4. Valid for data inputs of bushold parts (LVCH) only.

5. For data inputs only, control inputs do not have a bushold circuit.

6. The specified sustaining current at the data input holds the input below the specified V<sub>I</sub> level.

7. The specified overdrive current at the data input forces the data input to the opposite logic input state.

## 74LVC245A; 74LVCH245A

### AC CHARACTERISTICS

GND = 0 V;  $t_r = t_f \le 2.5$  ns.

	PARAMETER							
SYMBOL		WAVEFORMS	-40 to +85			-40 to +125		UNIT
			MIN.	TYP.	MAX.	MIN.	MAX.	
V <sub>CC</sub> = 1.2	V							
t <sub>PHL</sub> /t <sub>PLH</sub>	propagation delay $A_n$ to $B_n$ ; $B_n$ to $A_n$	see Figs 4 and 6	-	17	-	-	-	ns
t <sub>PZH</sub> /t <sub>PZL</sub>	$\frac{3}{\overline{OE}}$ to $A_n$ ; $\overline{OE}$ to $B_n$	see Figs 5 and 6	-	22	-	-	-	ns
t <sub>PHZ</sub> /t <sub>PLZ</sub>	$\overline{OE}$ to A <sub>n</sub> ; $\overline{OE}$ to B <sub>n</sub>	see Figs 5 and 6	-	12	-	-	-	ns
$V_{\rm CC} = 2.7$	v	1		•			•	
t <sub>PHL</sub> /t <sub>PLH</sub>	propagation delay $A_n$ to $B_n$ ; $B_n$ to $A_n$	see Figs 4 and 6	1.5	3.4	7.3	1.5	9.5	ns
t <sub>PZH</sub> /t <sub>PZL</sub>	$\frac{3}{\overline{OE}}$ to $A_n$ ; $\overline{OE}$ to $B_n$	see Figs 5 and 6	1.5	5.0	9.5	1.5	12.0	ns
t <sub>PHZ</sub> /t <sub>PLZ</sub>	$\overline{OE}$ to A <sub>n</sub> ; $\overline{OE}$ to B <sub>n</sub>	see Figs 5 and 6	1.5	3.6	8.0	1.5	10.0	ns
V <sub>CC</sub> = 3.0	to 3.6 V; note 1			1	4		1	
t <sub>PHL</sub> /t <sub>PLH</sub>	propagation delay $A_n$ to $B_n$ ; $B_n$ to $A_n$	see Figs 4 and 6	1.5	2.9	6.3	1.5	8.0	ns
t <sub>PZH</sub> /t <sub>PZL</sub>	$\overline{OE}$ to A <sub>n</sub> ; $\overline{OE}$ to B <sub>n</sub>	see Figs 5 and 6	1.5	4.0	8.5	1.5	11.0	ns
t <sub>PHZ</sub> /t <sub>PLZ</sub>	$\overline{OE}$ to A <sub>n</sub> ; $\overline{OE}$ to B <sub>n</sub>	see Figs 5 and 6	1.7	3.4	7.0	1.7	9.0	ns
t <sub>sk(0)</sub>	skew	note 2			1.0		1.5	ns

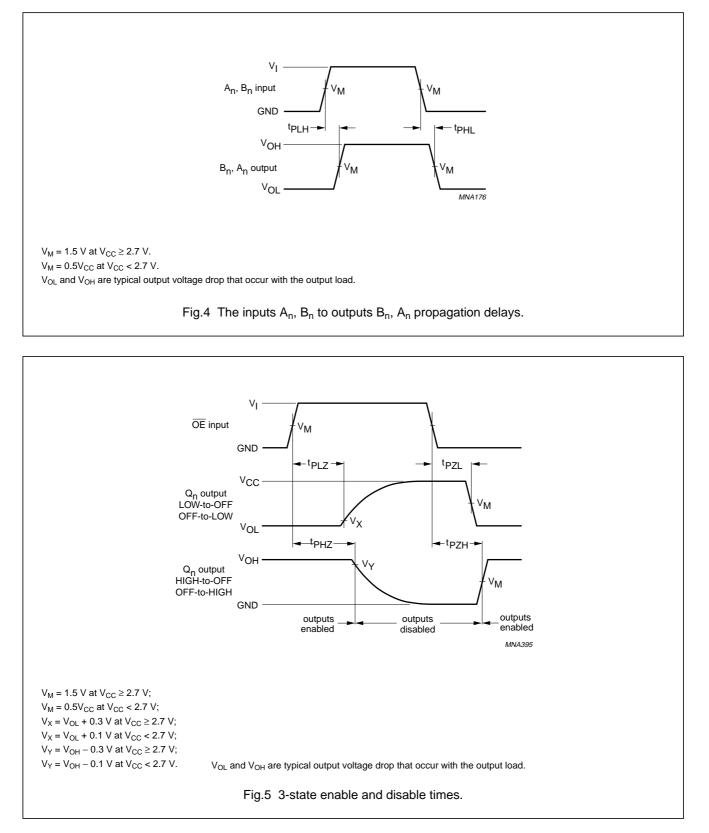
#### Notes

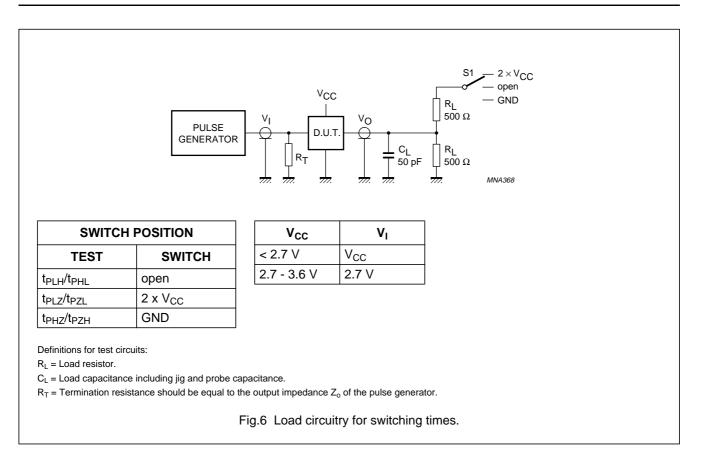
1. Typical values are measured at  $V_{CC}$  = 3.3 V.

2. Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by design.

## 74LVC245A; 74LVCH245A

### AC WAVEFORMS





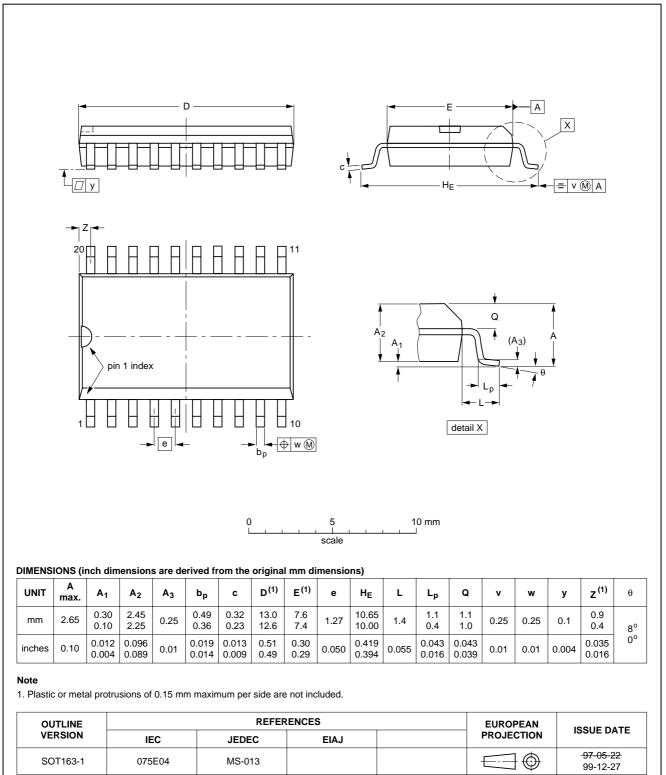
SOT163-1

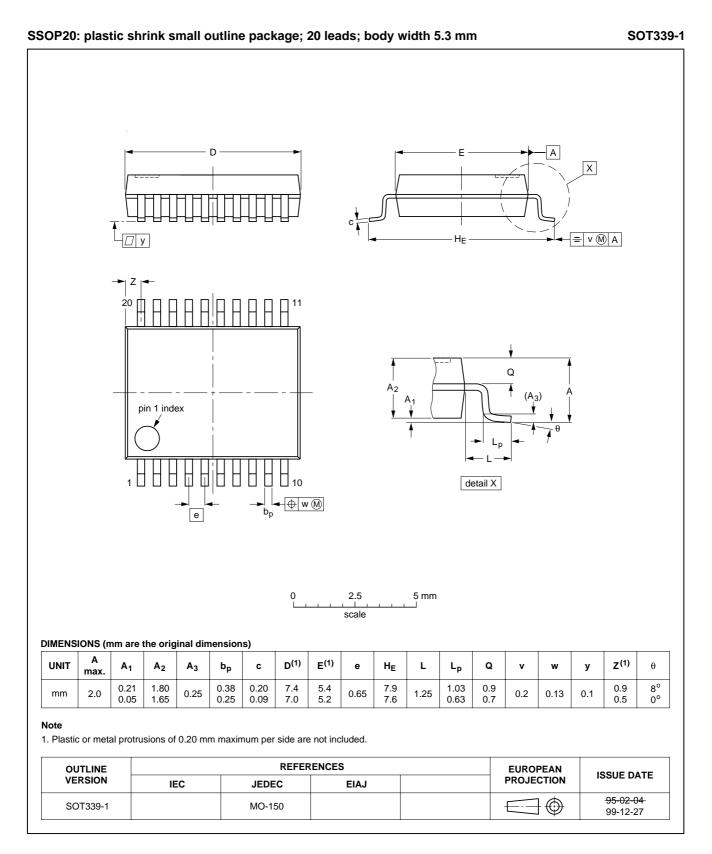
## Octal bus transceiver with direction pin with 5 Volt tolerant input/outputs (3-state)

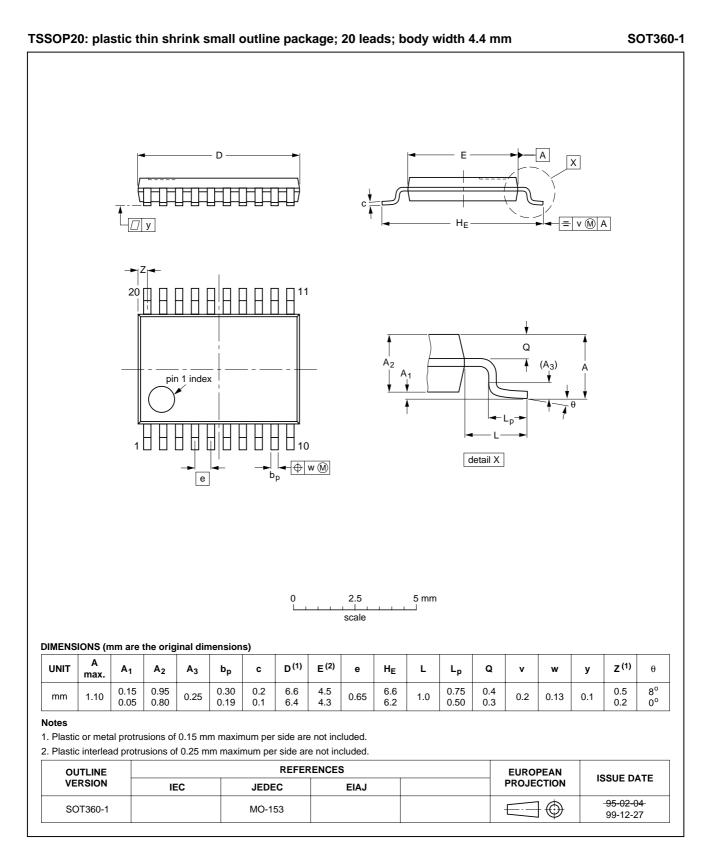
## 74LVC245A; 74LVCH245A

### PACKAGE OUTLINES









## 74LVC245A; 74LVCH245A

### SOLDERING

#### Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"Data Handbook IC26; Integrated Circuit Packages"* (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

#### **Reflow soldering**

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferable be kept below 220 °C for thick/large packages, and below 235 °C for small/thin packages.

#### Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
  - larger than or equal to 1.27 mm, the footprint longitudinal axis is preferred to be parallel to the transport direction of the printed-circuit board;
  - smaller than 1.27 mm, the footprint longitudinal axis must be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

• For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C. A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

### Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320  $^\circ\text{C}.$ 

## 74LVC245A; 74LVCH245A

#### Suitability of surface mount IC packages for wave and reflow soldering methods

	SOLDERING METHOD			
FACKAGE	WAVE	REFLOW <sup>(2)</sup>		
BGA, LBGA, LFBGA, SQFP, TFBGA, VFBGA	not suitable	suitable		
HBCC, HBGA, HLQFP, HSQFP, HSOP, HTQFP, HTSSOP, HVQFN, HVSON, SMS	not suitable <sup>(3)</sup>	suitable		
PLCC <sup>(4)</sup> , SO, SOJ	suitable	suitable		
LQFP, QFP, TQFP	not recommended <sup>(4)(5)</sup>	suitable		
SSOP, TSSOP, VSO	not recommended <sup>(6)</sup>	suitable		

#### Notes

- 1. For more detailed information on the BGA packages refer to the "(*LF*)BGA Application Note" (AN01026); order a copy from your Philips Semiconductors sales office.
- 2. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the *"Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods"*.
- 3. These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.
- 4. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- 5. Wave soldering is suitable for LQFP, TQFP and QFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
- 6. Wave soldering is suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

## 74LVC245A; 74LVCH245A

#### DATA SHEET STATUS

DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITIONS
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A.

#### Notes

- 1. Please consult the most recently issued data sheet before initiating or completing a design.
- 2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

#### DEFINITIONS

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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